

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination CHUNG ET AL.	
		Examiner Andrew Schechter	Art Unit 2871	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5511591	04-1996	Abe	141/7
	C	US-5247377	09-1993	Omeis et al.	359/76
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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